



NPN MEDIUM POWER SILICON **TRANSISTOR**

Qualified per MIL-PRF-19500/393

Qualified Levels: JAN, JANTX and **JANTXV**

DESCRIPTION

This family of high-frequency, epitaxial planar transistors feature low saturation voltage. These devices are also available in TO-39 and low profile U4 packaging. Microsemi also offers numerous other transistor products to meet higher and lower power ratings with various switching speed requirements in both through-hole and surface-mount packages.

Important: For the latest information, visit our website http://www.microsemi.com.

FEATURES

- JEDEC registered 2N3418 through 2N3421 series.
- JAN, JANTX, and JANTXV qualifications are available per MIL-PRF-19500/393.
- RoHS compliant versions available (commercial grade only).
- $V_{CE(sat)} = 0.25 \text{ V } @ \text{I}_{C} = 1 \text{ A}.$
- Rise time $t_r = 0.22 \ \mu s \ max \ @ \ I_C = 1.0 \ A, \ I_{B1} = 100 \ mA.$
- Fall time $t_f = 0.20 \mu s \text{ max } @ I_C = 1.0 \text{ A}, I_{B2} = -100 \text{ mA}.$

APPLICATIONS / BENEFITS

- General purpose transistors for medium power applications requiring high frequency switching and low package profile.
- Military and other high-reliability applications.



TO-5 Package

Also available in:

TO-39 package (short leaded) 🔁 <u>2N3418S – 2N3421Ś</u>

U4 package (surface mount) 2N3418U4 – 2N3421U4

MAXIMUM RATINGS

Parameters / Test Conditions	Symbol	2N3418 2N3420	2N3419 2N3421	Unit
Collector-Emitter Voltage	V_{CEO}	60	80	V
Collector-Base Voltage	V_{CBO}	85 125		V
Emitter-Base Voltage	V_{EBO}	8		V
Collector Current tp <= 1 ms, duty cycle <= 50%	Ic	3 5		Α
Total Power Dissipation	P _D	1 5		W
Operating & Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200		°C

- **Notes:** 1. Derate linearly 5.72 mW/°C for $T_A > +25$ °C.
 - 2. Derate linearly 150 mW/°C for $T_C > +100$ °C.

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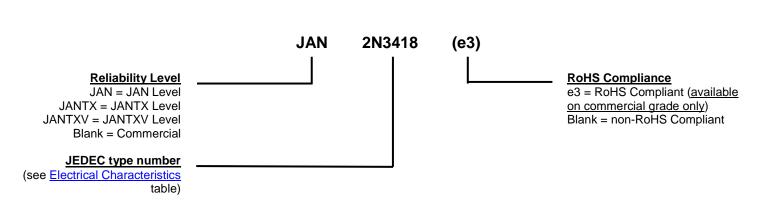
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MECHANICAL and PACKAGING

- CASE: Hermetically sealed, kovar base, nickel cap
 MARKING: Part number, date code, manufacturer's ID
- POLARITY: See Package Dimensions on last page.

PART NOMENCLATURE



SYMBOLS & DEFINITIONS					
Symbol	Definition				
C_obo	Common-base open-circuit output capacitance.				
I _{CEO}	Collector cutoff current, base open.				
I _{CEX}	Collector cutoff current, circuit between base and emitter.				
I _{EBO}	Emitter cutoff current, collector open.				
h _{FE}	Common-emitter static forward current transfer ratio.				
V_{CEO}	Collector-emitter voltage, base open.				
V_{CBO}	Collector-emitter voltage, emitter open.				
V_{EBO}	Emitter-base voltage, collector open.				



ELECTRICAL CHARACTERISTICS (T_A = +25°C, unless otherwise noted)

OFF CHARACTERISTICS

Parameters / Test Conditions		Symbol	Min.	Max.	Unit
Collector-Emitter Breakdown Current					
$I_{\rm C} = 50 \text{ mA}, I_{\rm B} = 0$	2N3418, 2N3420 2N3419, 2N3421	$V_{(BR)CEO}$	60 80		V
Collector-Emitter Cutoff Current					
$V_{BE} = -0.5 \text{ V}, V_{CE} = 80 \text{ V}$	2N3418, 2N3420			0.3	
$V_{BE} = -0.5 \text{ V}, V_{CE} = 120 \text{ V}$	2N3419, 2N3421	I _{CEX}		0.3	μΑ
Collector-Base Cutoff Current					
$V_{CE} = 45 \text{ V}, I_{B} = 0$	2N3418, 2N3420			5.0	
$V_{CE} = 60 \text{ V}, I_{B} = 0$	2N3419, 2N3421	I _{CEO}		5.0	μΑ
Emitter-Base Cutoff Current					
$V_{EB} = 6.0 \text{ V}, I_{C} = 0$				0.5	
$V_{EB} = 8.0 \text{ V}, I_{C} = 0$		I _{EBO}		10	μΑ

ON CHARACTERISTICS (1)

Parameters / Test Conditions		Symbol	Min.	Max.	Unit
Forward-Current Transfer Ratio					
$I_C = 100 \text{ mA}, V_{CE} = 2.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421		20 40		
$I_C = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421	h _{FE}	20 40	60 120	
$I_C = 2.0 \text{ A}, V_{CE} = 2.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421		15 30		
$I_C = 5.0 \text{ A}, V_{CE} = 5.0 \text{ V}$	2N3418, 2N3419 2N3420, 2N3421		10 15		
Collector-Emitter Saturation Voltage					
$I_C = 1.0 \text{ A}, I_B = 0.1 \text{ A}$ $I_C = 2.0 \text{ A}, I_B = 0.2 \text{ A}$		$V_{CE(sat)}$		0.25 0.5	V
Base-Emitter Saturation Voltage $I_C = 1.0 \text{ A}, I_B = 0.1 \text{ A}$ $I_C = 2.0 \text{ A}, I_B = 0.2 \text{ A}$		$V_{BE(sat)}$	0.6 0.7	1.2 1.4	V

DYNAMIC CHARACTERISTICS

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Magnitude of Common Emitter Small-Signal Short Circuit Forward Current Transfer Ratio $I_C = 0.1 \text{ A}, V_{CE} = 10 \text{ V}, f = 20 \text{ MHz}$	h _{fe}	1.3	0.8	
Output Capacitance $V_{CB} = 10 \text{ V}, I_E = 0, 100 \text{ kHz} \le f \le 1.0 \text{ MHz}$	C_obo		150	pF

NOTES: (1) Pulse Test: Pulse Width = 300 μ s, Duty Cycle \leq 2.0%.



ELECTRICAL CHARACTERISTICS (T_A = +25°C, unless otherwise noted) continued

SWITCHING CHARACTERISTICS

Parameters / Test C	rameters / Test Conditions (for all symbols)		Min.	Max.	Unit
Delay Time Rise Time	$V_{BE(off)} = -3.7 \text{ V},$ $I_C = 1.0 \text{ A}, I_{B1} = 100 \text{ mA}$	t _d t _r		0.08 0.22	μs
Storage Time Fall Time	$V_{BE(off)} = -3.7 \text{ V},$ $I_C = 1.0 \text{ A}, I_{B2} = -100 \text{ mA}$	t _s		1.10 0.20	μs
Turn-Off Time	$V_{BE(off)} = -3.7 \text{ V}, I_{C} = 1.0 \text{ A},$ $I_{B2} = -100 \text{ mA}, R_{L} = 20 \Omega$	t _{off}	t _{off}	1.20	μs

SAFE OPERATING AREA

DC Test

 $T_C = +100 \, ^{\circ}C$, 1 cycle, $t \ge 1.0 \, s$

Test 1

 V_{CE} = 5.0 V, I_{C} = 3.0 A

Test 2

 $V_{CE} = 37 \text{ V}, I_{C} = 0.4 \text{ A}$

Test 3

 $V_{CE} = 60 \text{ V}, I_{C} = 0.185 \text{ A}$ 2N3418, 2N3420 $V_{CE} = 80 \text{ V}, I_{C} = 0.12 \text{ A}$ 2N3419, 2N3421

Clamped Switching $T_A = +25 \, ^{\circ}\text{C}, I_B = 0.5 \, \text{A}, I_C = 3.0 \, \text{A}$



GRAPHS

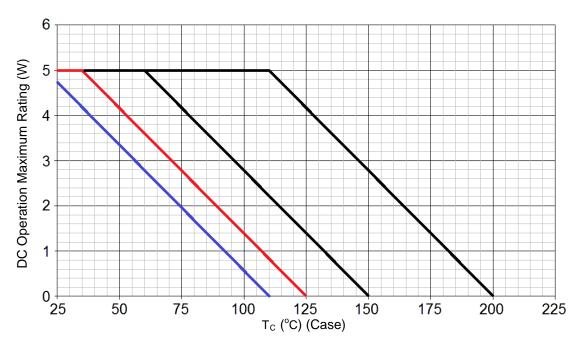


FIGURE 1

NOTES: Thermal Resistance Junction to Case = 4.5 °C/W

Max Finish-Alloy Temp = 175 °C

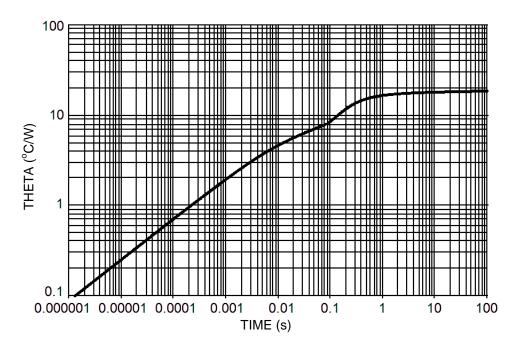


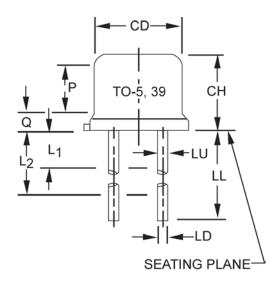
FIGURE 2

Maximum Thermal Impedance

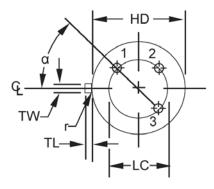
NOTE: T_C = +25 °C, Thermal Resistance $R_{\theta JC}$ = 4.5 °C/W



PACKAGE DIMENSIONS



	Dimensions					
Symbol	In	ch	Millimeters		Note	
	Min	Max	Min	Max		
CD	.305	.335	7.75	8.51		
CH	.240	.260	6.10	6.60		
HD	.335	.370	8.51	9.40		
LC	.200) TP	5.08 TP		6	
LD	.016	.021	0.41	0.53		
LL	.500	.750	12.7	19.05	7	
LU	See notes 7, 13, 14					
L ₁		.050		1.27	7	
L ₂	.250		6.35		7	
Р	.100		2.54		5	
Q		.040		1.02	4	
TL	.029	.045	0.74	1.14	3, 10	
TW	.028	.034	0.71	.86	9, 10	
r		.010		0.25	11	
α	45°	TP	45°	TP	6	



- 1. Dimensions are in inches.
- 2. Millimeters are given for general information only.
- Symbol TL is measured from HD maximum.
- 4. Details of outline in this zone are optional.
- 5. Symbol CD shall not vary more than .010 inch (0.25 mm) in zone P. This zone is controlled for automatic handling.
- 6. Léads at gauge plane .054 inch (1.37 mm) +.001 inch (0.03 mm) -.000 inch (0.00 mm) below seating plane shall be within .007 inch (0.18 mm) radius of TP relative to tab. Device may be measured by direct methods or by gauge.
- 7. Symbol LU applies between L1 and L2. Dimension LD applies between L2 and LL minimum. Diameter is uncontrolled in L1 and beyond LL minimum.
- 8. Lead number 3 is electrically connected to case.
- 9. Beyond r maximum, TW shall be held for a minimum length of .021 inch (0.53 mm).
- 10. Lead number 4 omitted on this variation.
- 11. Symbol r applied to both inside corners of tab.
- 12. For transistor types 2N3418, 2N3419, 2N3420, 2N3421, LL is 1.500 (38.10 mm) minimum, and 1.750 (44.45 mm) maximum.
- 13. In accordance with ASME Y14.5M, diameters are equivalent to Φx symbology.
- 14. Lead 1 is emitter, lead 2 is base, and lead 3 is collector.